Application/Control No. Applicant(s)/Patent Under Reexamination 10/643,934 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Thoi V. Duong 2871 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-6,331,881 B1 12-2001 Hatano et al. 349/86 В US-С US-US-D E US-US-F G US-US-Н US-J US-Κ US-US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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